Fluctuation X-ray microscopy: a novel approach for examining medium-range order in non-crystalline systems

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Measuring medium-range order is a challenging and important problem in the structural study of disordered materials. Many x-ray techniques exist to probe long- and short-range order in matter. At present no x-ray technique effectively probes medium-range order. We have developed a technique, which we call fluctuation x-ray microscopy that offers quantitative insight into medium-range correlations in disordered materials at nanometer- and largerlength scales. For FXM setup, a modified scanning transmission soft x-ray microscopy configuration was used. The technique requires coherent x-ray beam and examines spatially resolved fluctuations in the intensity of soft x-ray speckle patterns. The speckle variance depends on higher-order correlations that are more sensitive to medium-range order. Systematically measuring the coherent speckle variance as a function of the scattering vector and the x-ray spot size produces a fluctuation map that contains information about the degree of medium-range order and the correlation length. FXM is better suited for studying materials with nanometer and larger characteristic length scales. It can explore the mediumrange order and subtle spatial structural changes in a wide range of disordered materials from soft matter to nanowire arrays and magnetic materials. To demonstrate this new technique at micronlength scales, we studied a model system comprised of polystyrene latex spheres. Using nanofocusing optics, we have further developed fluctuation x-ray microscopy for the study of nanomaterials. The medium-range order correlation of nanostructures self-assembled from two hybrids of PI-b-PEO/ aluminosilicates was quantitatively examined and compared by fluctuation x-ray microscopy.

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